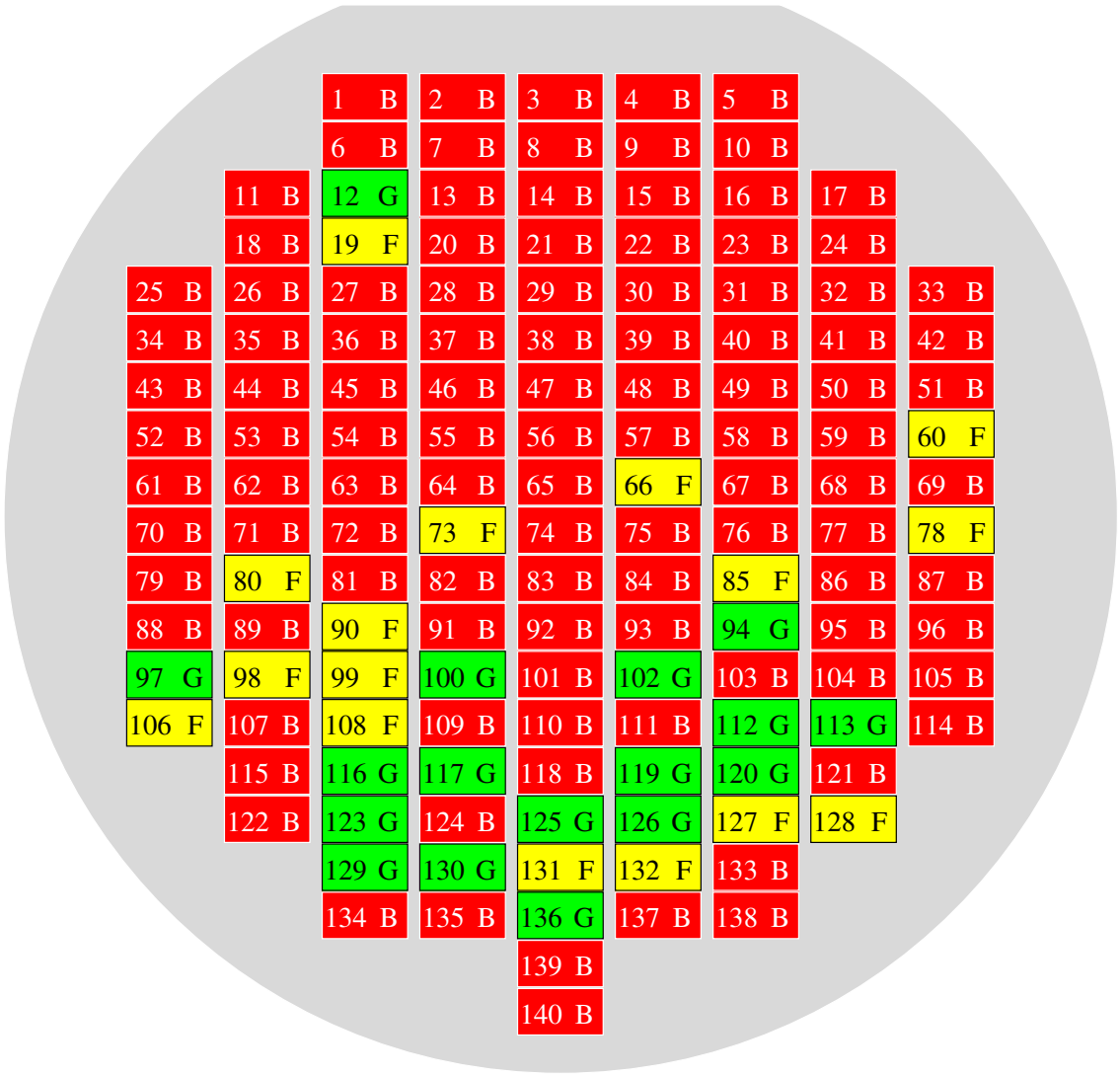
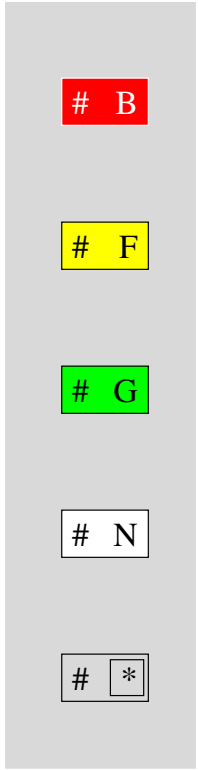
Die quality map for wafer 70 s/n: Y21316-08-03

Date: 06/30/99





Bad die

Fair die

Good die

No info

Manually tagged